



NEW ENGLAND SEMICONDUCTOR

2N3789
2N3790
2N3791*
2N3792*

*also available as
JAN, JANTX,
JANTXV

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristics	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Collector-Emitter Sustaining Voltage (1) $I_C = 200 \text{ mAdc}, I_B = 0$ 2N3789, 2N3791 2N3790, 2N3792	$V_{CE(sus)}$	60 80		Vdc
Collector-Emitter Cutoff Current $V_{CE} = 60 \text{ Vdc}, V_{BE} = -1.5 \text{ Vdc}$ 2N3789, 2N3791 $V_{CE} = 80 \text{ Vdc}, V_{BE} = -1.5 \text{ Vdc}$ 2N3790, 2N3792 $V_{CE} = 60 \text{ Vdc}, V_{BE} = -1.5 \text{ Vdc}, T_C = 150^\circ\text{C}$ 2N3789, 2N3791 $V_{CE} = 80 \text{ Vdc}, V_{BE} = -1.5 \text{ Vdc}, T_C = 150^\circ\text{C}$ 2N3790, 2N3792	I_{CEX}		1.0 1.0 5.0 5.0	mAdc
Emitter-Base Cutoff Current $V_{EB} = 7.0 \text{ Vdc}$ All Types	I_{EBO}		5.0	mAdc
ON CHARACTERISTICS				
DC Current Gain (1) $I_C = 1.0 \text{ Adc}, V_{CE} = 2.0 \text{ Vdc}$ 2N3789, 2N3790 2N3791, 2N3792 $I_C = 3.0 \text{ Adc}, V_{CE} = 2.0 \text{ Vdc}$ 2N3789, 2N3790 2N3791, 2N3792	h_{FE}	25 50 15 30	90 180 - -	-
Collector-Emitter Saturation Voltage (1) $I_C = 4.0 \text{ Adc}, I_B = 0.4 \text{ Adc}$ 2N3789, 2N3790 $I_C = 5.0 \text{ Adc}, I_B = 0.5 \text{ Adc}$ 2N3791, 2N3792	$V_{CE(sat)}$		1.0 1.0	Vdc
Base-Emitter On Voltage (1) $I_C = 5.0 \text{ Adc}, V_{CE} = 2.0 \text{ Vdc}$ 2N3789, 2N3790 2N3791, 2N3792 $I_C = 10 \text{ Adc}, V_{CE} = 4.0 \text{ Vdc}$ All Types	$V_{BE(on)}$		2.0 1.8 4.0	Vdc
DYNAMIC CHARACTERISTICS				
Current Gain -- Bandwidth Product $V_{CE} = 10 \text{ Vdc}, I_C = 0.5 \text{ Adc}, f = 1.0 \text{ MHz}$ All Types	f_T	4.0		MHz

(1) Sweep Test: 1/2 Sine Wave Cycle @ 60 cps.

SX LEVEL RELIABILITY TESTING

100% SCREENING	GROUP A	GROUP B (Sample)	GROUP C (Sample)
Internal Visual Temp Cycle Thermal Response Constant Acceleration PIND Fine and Gross Leak HTRB Power Burn In	Visual and Mechanical DC Static Tests 25°C DC Static Tests High Temp DC Static Tests Low Temp Dynamic Tests @ 25°C	Solderability Temp Cycle Fine and Gross Leak Bond Strength Intermittent Op Life Steady State Op Life Thermal Resistance Hi-Temp (non-operating)	Physical Dimensions Thermal Shock Terminal Strength Hermetic Seal Moisture Resistance Shock Test Vibration Test Constant Acceleration Salt Atmosphere Operation Life

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